

High Temperature Silicon Carbide Power Schottky Diode

V_{RRM}	=	1200 V
I_F (T_C=25°C)	=	2.5 A
Q_C	=	6 nC

Features

- 1200 V Schottky rectifier
- 250°C maximum operating temperature
- Electrically isolated base-plate
- Zero reverse recovery charge
- Superior surge current capability
- Positive temperature coefficient of V_F
- Temperature independent switching behavior
- Lowest figure of merit Q_C/I_F
- Available screened to Mil-PRF-19500

Package

- RoHS Compliant



TO – 257 (Isolated Base-plate Hermetic Package)

Advantages

- High temperature operation
- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Industry's lowest reverse recovery charge
- Industry's lowest device capacitance
- Ideal for output switching of power supplies
- Best in class reverse leakage current at operating temperature

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- High Temperature DC/DC Converters
- High Temperature Motor and Servo Drives
- High Temperature Inverters
- High Temperature Actuator Control
- Military Power Supplies

Maximum Ratings at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V _{RRM}		1200	V
Continuous forward current	I _F	T _C = 25 °C	2.5	A
Continuous forward current	I _F	T _C ≤ 225 °C	0.75	A
RMS forward current	I _{F(RMS)}	T _C ≤ 225 °C	1.3	A
Surge non-repetitive forward current, Half Sine Wave	I _{F,SM}	T _C = 25 °C, t _p = 10 ms	8	A
Non-repetitive peak forward current	I _{F,max}	T _C = 25 °C, t _p = 10 μs	65	A
I ² t value	∫I ² dt	T _C = 25 °C, t _p = 10 ms	0.5	A ² S
Power dissipation	P _{tot}	T _C = 25 °C	26	W
Operating and storage temperature	T _j , T _{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode forward voltage	V _F	I _F = 0.75 A, T _j = 25 °C I _F = 0.75 A, T _j = 210 °C	1.7 2.8			V
Reverse current	I _R	V _R = 1200 V, T _j = 25 °C V _R = 1200 V, T _j = 250 °C	1 10	10	100	μA
Total capacitive charge	Q _C	I _F ≤ I _{F,MAX} dI _F /dt = 200 A/μs T _j = 210 °C	V _R = 400 V V _R = 960 V	6 11		nC
Switching time	t _s		V _R = 400 V V _R = 960 V	< 17		ns
Total capacitance	C	V _R = 1 V, f = 1 MHz, T _j = 25 °C V _R = 400 V, f = 1 MHz, T _j = 25 °C V _R = 1000 V, f = 1 MHz, T _j = 25 °C	66 10 8			pF

Thermal Characteristics

Thermal resistance, junction - case	R _{thJC}	9.52	°C/W
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Mechanical Properties

Mounting torque	M	0.6	Nm
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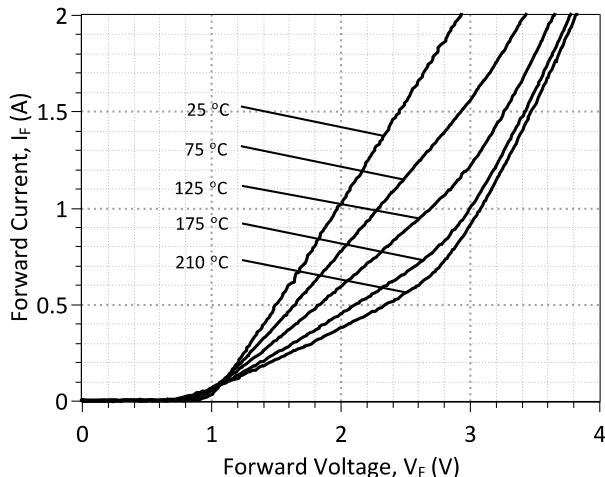


Figure 1: Typical Forward Characteristics

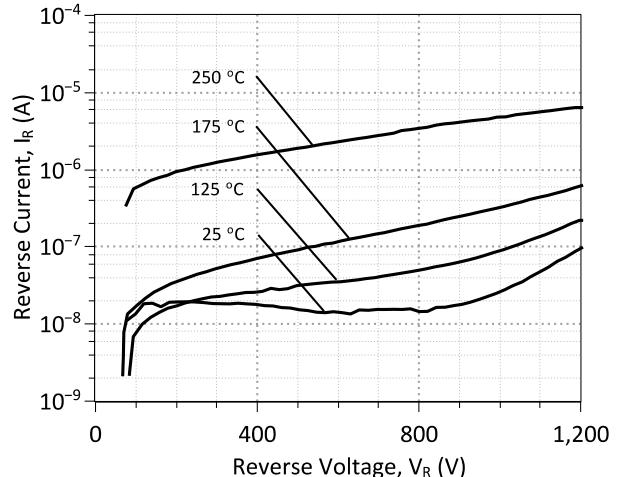


Figure 2: Typical Reverse Characteristics

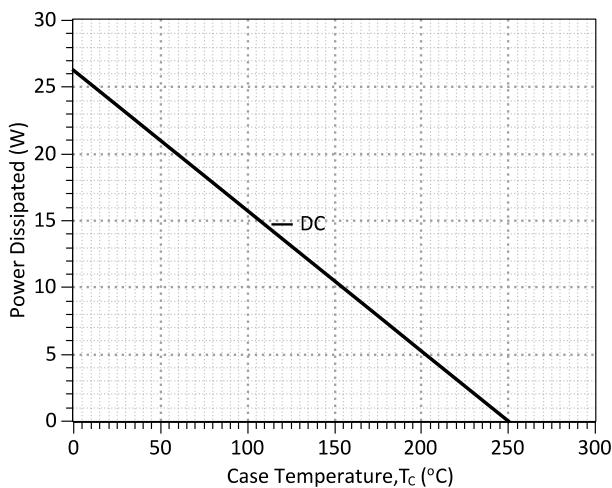


Figure 3: Power Derating Curve

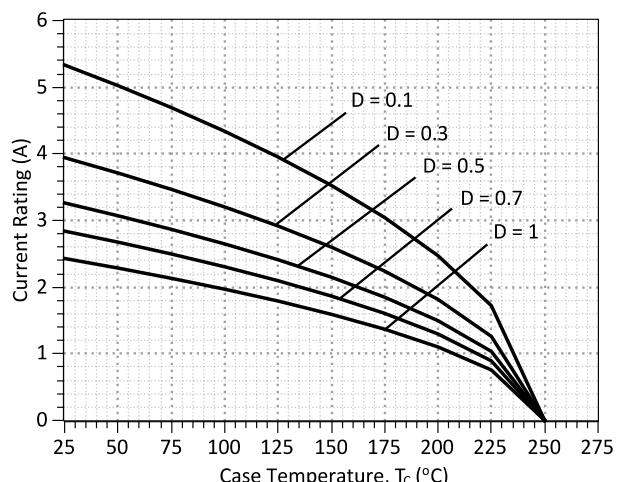


Figure 4: Current Derating Curves ($D = t_p/T$, $t_p = 400 \mu s$)
 (Considering worst case Z_{th} conditions)

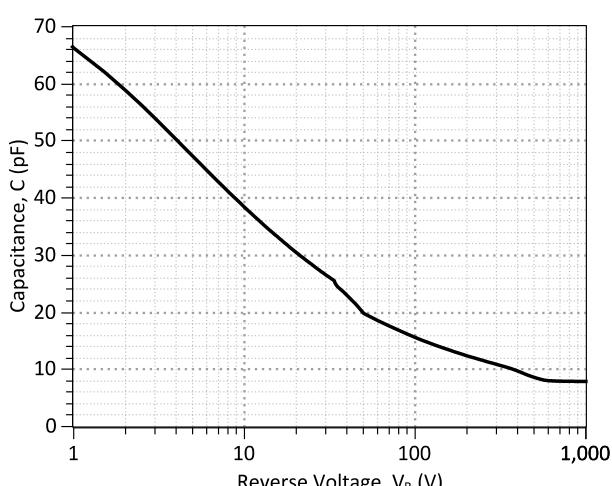


Figure 5: Typical Junction Capacitance vs Reverse Voltage Characteristics

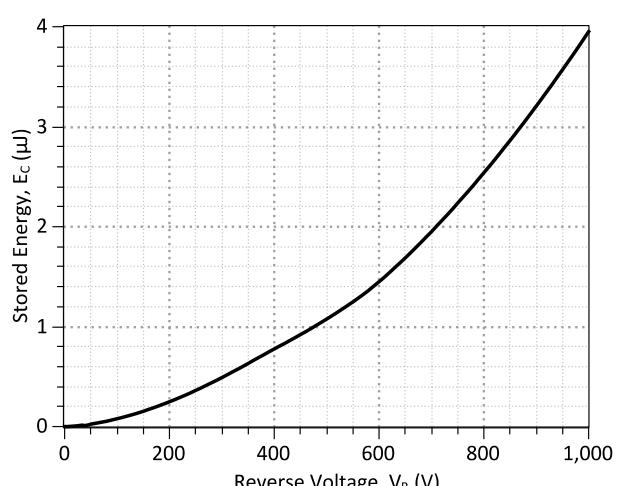


Figure 6: Typical Switching Energy vs Reverse Voltage Characteristics

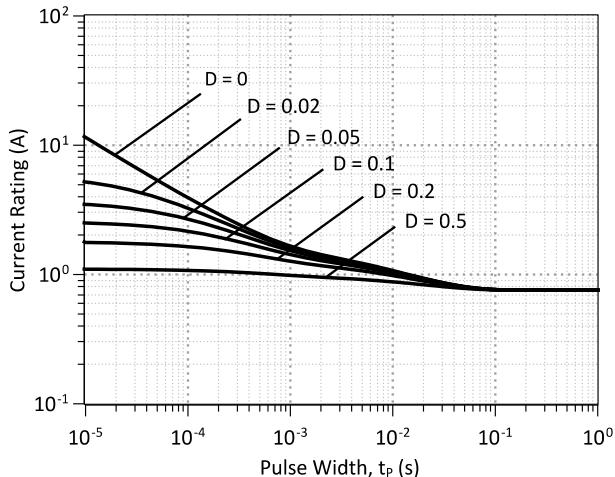


Figure 7: Current vs Pulse Duration Curves at $T_c = 225\text{ }^\circ\text{C}$

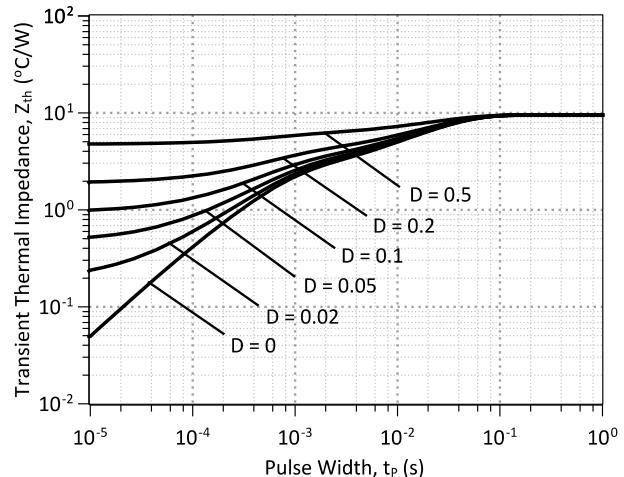
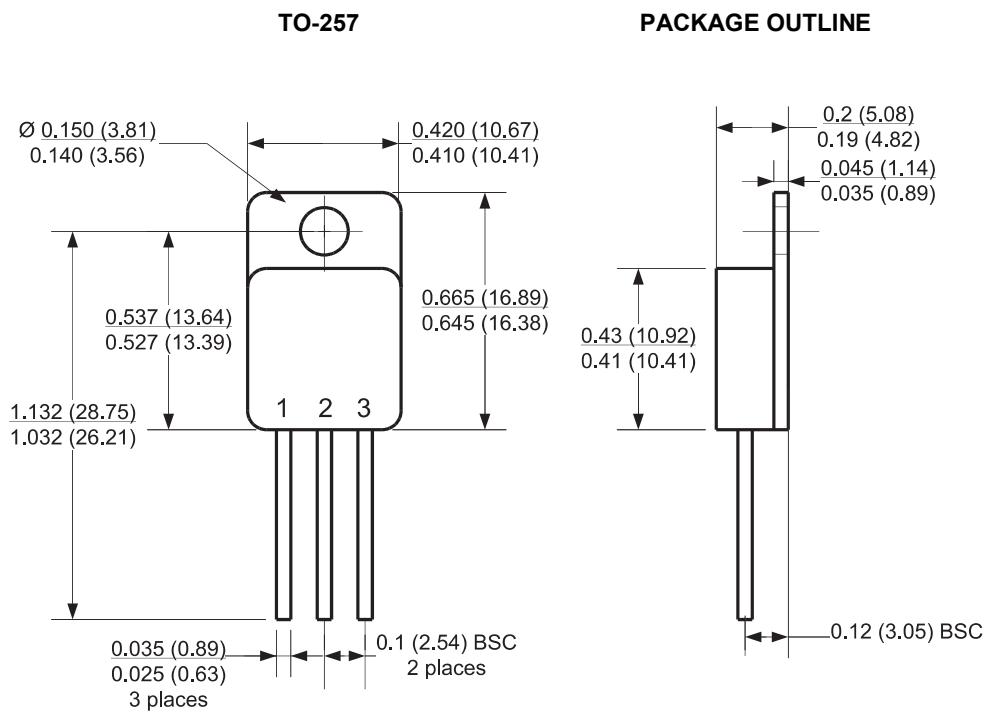


Figure 8: Transient Thermal Impedance

Package Dimensions:



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2014/08/26	1	Updated Electrical Characteristics	
2012/04/24	0	Initial release	

Published by

GeneSiC Semiconductor, Inc.
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Dulles, VA 20166

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SPICE Model Parameters

This is a secure document. Copy this code from the SPICE model PDF file on our website into a SPICE software program for simulation of the 1N8024-GA.

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* MODEL OF GeneSiC Semiconductor Inc.
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* $Revision: 1.0      $
* $Date: 05-SEP-2013  $
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* GeneSiC Semiconductor Inc.
* 43670 Trade Center Place Ste. 155
* Dulles, VA 20166
*
* COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
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*
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
*
* Start of 1N8024-GA SPICE Model
*
.SUBCKT 1N8024 ANODE KATHODE
R1 ANODE INT R=((TEMP-24)*0.0099); Temperature Dependant Resistor
D1 INT KATHODE 1N8024_25C; Call the 25C Diode Model
D2 ANODE KATHODE 1N8024_PIN; Call the PiN Diode Model
.MODEL 1N8024_25C D
+ IS      1.88E-18      RS      0.9255
+ N       1              IKF     98.29122743
+ EG      1.2            XTI     3
+ CJO     7.90E-11      VJ      0.367
+ M       1.63           FC      0.5
+ TT      1.00E-10      BV      1200
+ IBV     1.00E-03      VPK     1200
+ IAVE    1              TYPE    SiC_Schottky
+ MFG     GeneSiC_Semiconductor
.MODEL 1N8024_PIN D
+ IS      2.76E-16      RS      0.84243
+ N       3.791461      IKF     2.98675
+ EG      3.23           XTI     30
+ FC      0.5            TT      0
+ BV      1200           IBV     1.00E-03
+ VPK     1200           IAVE    1
+ TYPE    SiC_PiN
.ENDS
*
* End of 1N8024-GA SPICE Model

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